Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/625,994	CHANDRA ET AL.	
Examiner	Art Unit	

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Shick C. Hom

SEARCHED					
Class	Subclass	Date	Examiner		
370	216, 218, 223, 252, 259, 261,	12/23/2005	SH		
370	263, 389,	12/23/2005	SH		
370	392,	12/23/2005	SH		
370	395.3,	12/23/2005	SH		
370	395.31,	12/23/2005	SH		
370	392, 401,	12/23/2005	SH		
370	402	12/23/2005	SH		
709	203, 204	12/23/2005	SH		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	DATE	EXMR
East search	12/23/2005	SH